

A Guideline on the Usage of an Isolated Gate Driver to Efficiently Drive SiC MOSFETs

AND90063/D

This application note provides guidance on how to design the power supply topology of NCP5156x family isolated gate drivers when using Silicon Carbide (SiC) MOSFETs.

As new power transistors, such as SiC MOSFETs, are being increasingly used in power electronics systems, it has become necessary to use special drivers. Isolated gate drivers are designed for the highest switching speeds and system size constraints required by technologies such as SiC (Silicon carbide) and GaN (Gallium nitride), by providing reliable control over IGBT and MOSFET. Many designers in the power electronic industry are already expert users of MOSFET, and IGBT in power converter designs. However, 1200 V and 1700 V SiC MOSFETs have become a real alternative to using IGBTs in power applications.

This application note focuses on optimization the design of gate driving voltage for speed to minimize switching losses and to get the full benefit of the devices.

Main related drives are:

- [NCP51560](#)
- [NCP51561](#) & [NCV51561](#)
- [NCP51563](#) & [NCV51563](#).

There are many similarities between SiC MOSFETs and Si MOSFETs. However, some of the challenges faced by the designers of SiC MOSFETs is the control of the gate threshold voltage. SiC MOSFETs show more dependence upon gate voltage at the recommended gate drive voltage than silicon devices. SiC MOSFETs require a higher positive gate drive voltage (+20 V) and, depending on the application, a negative OFF gate voltage in the -2 V to -6 V

range because it exhibits lower Vgs threshold that could lead to unwanted Turn-ON of the SiC MOSFET. For more details, you can refer to document in note [1].

The following is a short summary of the minimum gate driving requirements:

- Similarly to traditional Si MOSFET drivers, deliver high peak currents at turn-on and turn-off to quickly charge/discharge the C_{GS} and C_{GD} capacitances.
- SiC MOSFETs have a lower R_{DS(on)} than Si MOSFETs. They are normally driven at a higher gate voltage, typically -5 V to 20 V, to enhance R_{DS(on)} and switching speed. In order to achieve the lowest R_{DS(on)} and the fastest turn-off speed and to provide dV/dt immunity, the SiC MOSFET gate driver should provide 20 V to 22 V and about -5 V respectively during the ON and OFF state of SiC MOSFETs.
- The body diode of a SiC MOSFET has a high voltage drop (about 4 V), but a low minority carrier lifetime. They have a significantly faster recovery and a lower recovery charge than that of Si MOSFETs.
- The output switching current (di/dt) is significantly higher with SiC MOSFETs than with Si MOSFETs. This affects DC bus ringing, EMI, and output stage losses.
- Mitigate the negative feedback effect of the source inductance by using a low inductance package – also consider co-packaging later.

For more details, you can refer to document in note [2].

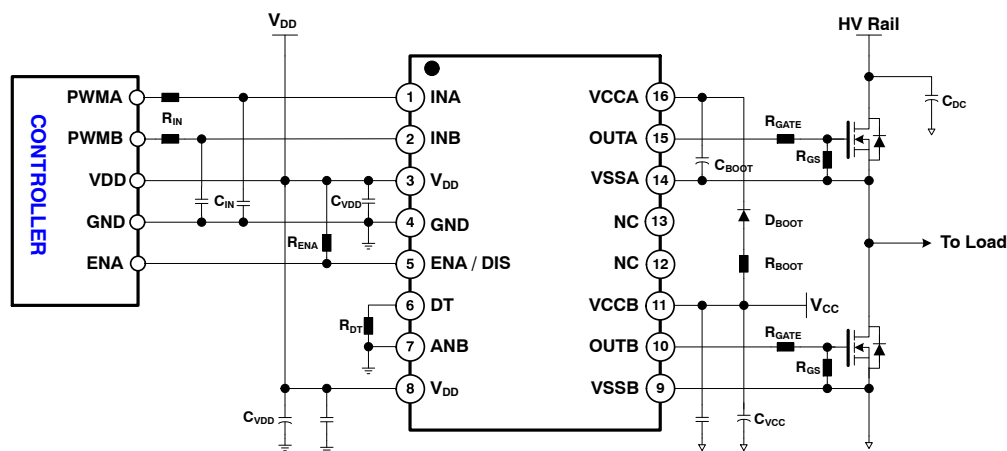


Figure 1. Typical Application Circuit

APPLICATINS INFORMATION

The NCP5156x family are isolated dual-channel gate drivers with 4.5 A/9.0 A source and sink peak current respectively. It implements reinforced isolation and can withstand 8 kV Peak and 5.7 kV_{RMS} isolation voltage and >200 V/ns common mode transient immunity (CMTI).

Consideration on the Gate Voltage for SiC MOSFET

The design of a SiC MOSFET gate driver is much like the design of a standard IGBT or silicon MOSFET driver.

SiC IGBTs gate voltage is typically driven from -8 V in the OFF state to +15 V in the ON state. For SiC MOSFETs, the voltage varies slightly to +18 V or +20 V in the ON state and -5 V in the OFF state. It is highly recommended to use a negative bias gate drive with SiC MOSFETs in switching applications because there could be ringing in the gate-source drive voltage of the power transistor during high di/dt and dv/dt switching cause of parasitic inductances are introduced by non-ideal PCB layout.

Driving the SiC MOSFET more aggressively at +20 V minimizes switching losses and improves the surge current rating for the SiC device, but it puts a greater voltage stress on the gate, which can affect the long-term reliability of the device. With slower devices, such as silicon MOSFETs and IGBTs, a negative bias gate drive is commonly used in power applications. There are two reasons for this:

- *Gate Drive Impedance* –The gate driver’s function is to turn the MOSFET ON and OFF (usually quickly) in order to reduce losses. To avoid cross conduction losses due to the Miller effect or due to slow switching with some loads, it is important for the driver to assert the off state with a lower impedance than the on-state drive on the opposing transistor. The negative gate drive margin plays an important part in reducing these losses
- *Source Inductance* – This is the inductance shared by the gate driver current loop and the output current loop. The negative gate drive voltage margin combined with the source lead inductance have a direct effect on the switching speed of the output under load. This is due to the source degeneration effect of the source inductance (the source lead inductance couples the output switching current back to the gate drive, slowing the gate drive)

The power supply of gate drive should be rated for at least 50 V/ns or above for the higher speed of SiC MOSFETs application. Most are not.

Gate Driver Specification for SiC MOSFET

The following is a short list of the minimum gate driving requirements: Compensating for the low gain while achieving efficient. High-speed switching imposes the following critical requirements for a SiC gate drive circuit:

- dv/dt transient immunity: At least ± 50 V/ns across the entire temperature range SiC MOSFETs are tailored to switch fast and operate at high frequencies, hence the intrinsic device dv/dt is higher than that observed on silicon IGBTs
- A SiC MOSFET specifies an asymmetrical max/min V_{GS} near the range of +25 V/ ± 10 V. The gate drive circuit must be capable of providing nearly the full range of 35 V, V_{GS} swing to take full advantage of the SiC MOSFET performance benefits. Given that the gate charge required to switch the device is low, the higher voltage swing doesn’t affect the required gate drive power. Most SiC MOSFETs will perform best when driven between -5 V > V_{GS} > 20 V. To cover the widest range of available SiC MOSFETs, the gate drive circuit should be able to withstand $V_{DD} = 25$ V and $V_{EE} = -10$ V
- V_{GS} must have fast rise and fall edges, on the order of a few ns
- Must be able to source high peak gate current on the order of several amps, across the entire Miller plateau region
- Sink current capability is driven by the need to provide a very low impedance hold-down or “clamp” as the V_{GS} falls below the Miller plateau. The sink current rating should exceed what would be required by merely having to discharge the input capacitance of a SiC MOSFET
- Must have VDD under-voltage lockout (UVLO) level that is matched to the requirement that $V_{GS} > \sim 16$ V before switching begins
- Low parasitic inductance for high-speed switching
- Small driver package able to be located as close as possible to the SiC MOSFET

Consideration on Application Circuits with Output Stage Negative Bias for SiC MOSFET

SiC MOSFET unique operating characteristics need to be carefully considered to fully benefit from SiC characteristics. The gate driver needs to be capable of providing +20 V and -2 V to -5 V negative bias with minimum output impedance and high current capability.

When parasitic inductances are introduced by non-ideal PCB layout and long package leads (e.g. TO-220 and TO-247 type packages), there could be ringing in the gate-source drive voltage of the power transistor during high di/dt and dv/dt switching. If the ringing is over the threshold voltage, there is the risk of unintended turn-on and even shoot-through. Applying a negative bias on the gate drive is a popular way to keep such ringing below the

threshold. Negative voltage can improve the noise tolerance of SiC MOSFET to suppress turning it unintentionally. The negative gate-source voltage makes the capacitance of Cgd becoming lower, which can reduce the ringing voltage.

Below are a few examples of implementing negative gate drive bias.

The first example with negative bias with two isolated-bias power supplies as shown in Figure 2. Power supply VHx determines the positive drive output voltage and VLx determines the negative turn-off voltage for each channels. This solution requires more power supplies than the conventional bootstrapped power supply example; however, it provides more flexibility when setting the positive, VHx, and negative, VLx, rail voltages.

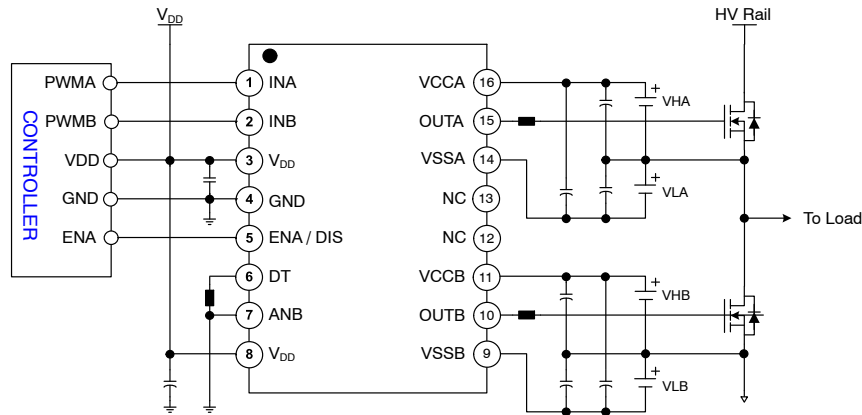


Figure 2. Negative Bias with Two Isolated-Bias Power Supplies

Figure 3 shows another example with negative bias turn-off on the gate driver using a Zener diode on an isolated power supply. The negative bias set by the voltage of Zener diode. For example, if the isolated power supply, VHx for each channels, the turn-off voltage will be -5.1 V and turn-on voltage will be 20 V - 5.1 V ≈ 15 V. Moreover, this configuration could easily be changed negative bias by using different Zener diode with the same 20 V isolated power supply.

This configuration needs two isolated power supplies for a half-bridge configuration, but this scheme is very simple.

However, it has the disadvantage of having a steady state power consumption from RZx. Therefore, one should be careful in selecting the RZx values. It is recommended that RZx allow the minimal current flow to stabilize the Zener clamping voltage (e.g. IZ : 5 mA ~ 10 mA).

Typical recommended values are in the few kohm range of SiC MOSFETs application.

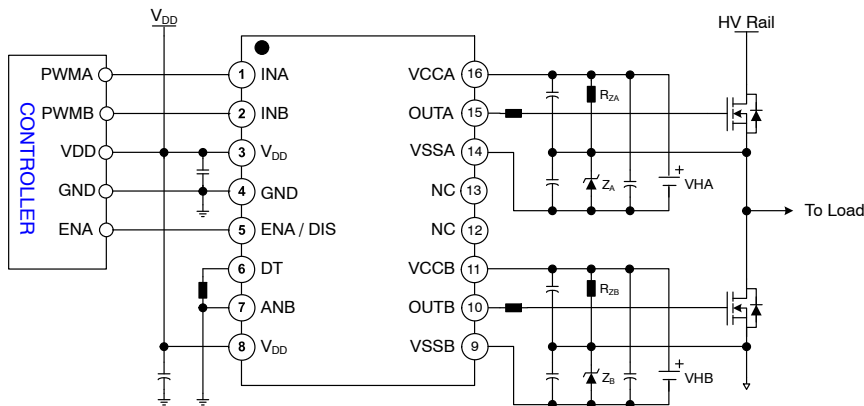


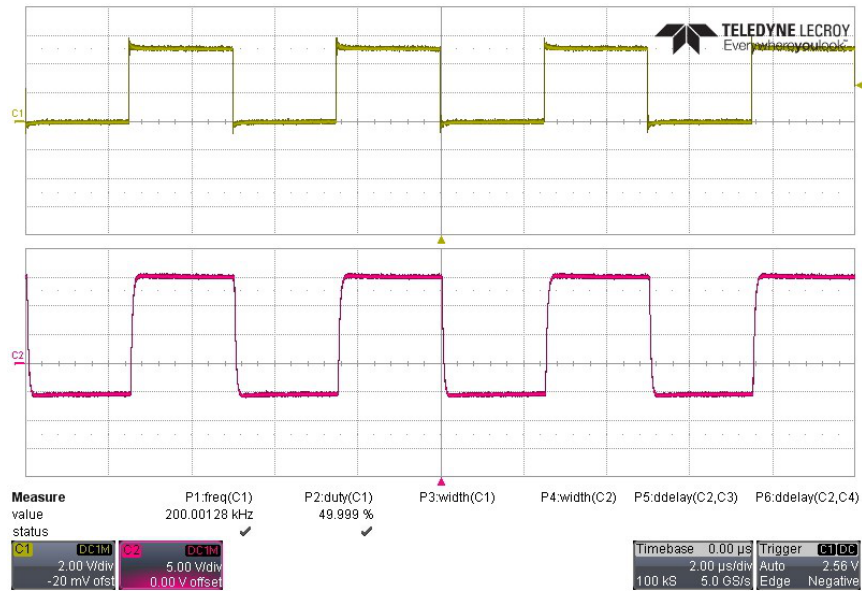
Figure 3. Negative Bias with Zener Diode on Single Isolated-Bias Power Supply

AND90063/D

Test Results

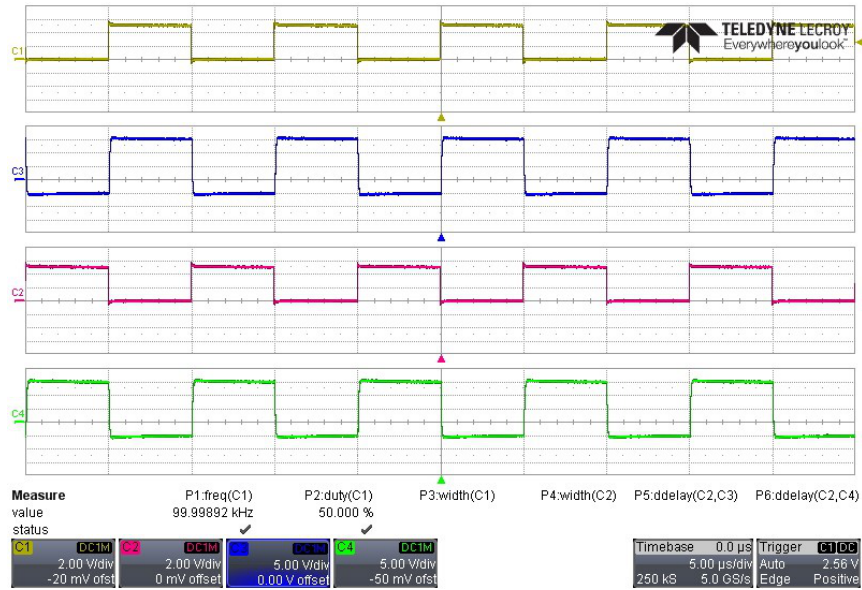
SiC MOSFET unique operating characteristics need to be carefully considered to fully benefit from SiC

characteristics. The gate driver needs to be capable of providing +20 V and -2 V to -5 V negative bias with minimum output impedance and high current capability.



CH1: INPUT [2 V/div], and CH2: OUTPUT [5 V/div]

Figure 4. Experimental Waveforms of Negative Bias with Zener Diode on Single Isolated Power Supply



CH1: INA [2 V/div], CH2: INB [2 V/div], CH3: OUTA [5 V/div], and CH4: OUTB [5 V/div]

Figure 5. Experimental Waveforms of Negative Bias with Zener Diode on Single Isolated Power Supply

AND90063/D

Related Product Information

LIST OF RELATED PRODUCTS

Device Family	Description	Package
NCP51560xy DWR2G	4.5/9-A Dual Channel Isolated Driver – 5/8/13/17 V UVLO – DIS – pin #7 NC	SOIC-WB 16 pins
NCP51561xy DWR2G	4.5/9-A Dual Channel Isolated Driver – 5/8/13/17 V UVLO – ENA/DIS	SOIC-WB 16 pins
NCV51561xy DWR2G	Automotive 4.5/9-A Dual Channel Isolated Driver – 5/8/13/17 V UVLO – ENA/DIS	SOIC-WB 16 pins
NCP51563xy DWR2G	4.5/9-A Dual Channel Isolated Driver – 5/8/13/17 V UVLO – ENA/DIS	SOIC-WB 14 pins
NCV51563xy DWR2G	Automotive 4.5/9-A Dual Channel Isolated Driver – 5/8/13/17 V UVLO – ENA/DIS	SOIC-WB 14 pins

Reference

[1] Micro Semiconductor Application note, "Design Recommendations for SiC MOSFETs"

[2] [TND6237/D](#), "SiC MOSFETs: Gate Drive Optimization", available on **onsemi** website

onsemi, **Onsemi**, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "**onsemi**" or its affiliates and/or subsidiaries in the United States and/or other countries. **onsemi** owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of **onsemi**'s product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. **onsemi** reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and **onsemi** makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT
North American Technical Support:
Voice Mail: 1 800-282-9855 Toll Free USA/Canada
Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:
Phone: 00421 33 790 2910
For additional information, please contact your local Sales Representative